

Mass spectra and incident energy resolved spectra after collisions of hydrocarbon ions with fusion-plasma tungsten thin films

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ABSTRACT

We have performed surface-induced dissociation studies of small deuterated hydrocarbon cations i.e. CD_x^+ with $x=2-4$, colliding with two types of tungsten-coated surfaces, in the incident energy range between $E_{in} = 0$ eV approximately, up to $E_{in} = 100$ eV. A 34 nm thick W layer deposited on stainless steel using the Thermionic Vacuum Arc (TVA) method and a small sample of a tile cut from ASDEX-Upgrade tiles, consisting of Plasma-Sprayed (PS) tungsten on carbon, are exposed to ion flux in these experiments. A double-focussing reverse geometry BE mass spectrometer, is used under ultra high vacuum conditions. Mass spectra of secondary charged particles are recorded via time-of-flight mass analyser. For comparison, we have performed equivalent study on polished stainless steel under experimental status explained in Section 2 below. At very low energies i.e. below 10 eV, only surface reflected projectiles are seen, whereas most of them are neutralized by surface micro charges. We observed that the fragmentation pattern of the small molecular ions at a given energy is strongly dependent on the surface. The roughness of both of the said thin films and their reflectivity for the projectile ion beam is studied by analysis of the ion yields of the reaction products.

Keywords: Plasma-Material Interactions, Fusion Relevant Materials, Ion-Surface Collisions

1. INTRODUCTION

Ion-surface collisions experiments have been a good source of yielding essential data for future fusion reactors. At the diverter and limiter regions of fusion devices, collisions of hypothermal plasma particles i.e. deuterium (D) or tritium (T) result physical processes like erosion. As a result, co-deposition of species may occur along with other particles. Thus the interaction of molecular ions with fusion relevant materials e.g. tungsten (W), beryllium (Be) and/or Carbon Fibre Composite (CFC) has been recognized and appreciated.

Tungsten has been replaced with carbon in many devices owing to its lower sputter yield and low

erosion under critical heat loads, therefore used at divertor in reactors like ASDEX and JET [1-4] and further proposed for ITER divertor [5]. Although tungsten has been studied the most of all fusion candidate materials, in last couple of years, but a complete knowledge of the effects of exposure to plasma constituents on tungsten has not yet been established [6,7].

Dissociation of small hydrocarbons CH_n^+ where $n = 1, 2, \dots$ and fluorocarbons CF_n^+ has been studied on aluminium surfaces for the study of surface processes [8]. Experiments of interacting SF_4^+ and SF_4^{2+} have been performed to investigate surface charge exchange and surface induced dissociations [9]. Recently, hydrocarbon covered W, Be and C surfaces

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are exposed to Nitrogen based gas phase cations, proving that the heterogeneous reactions occur only with the surface adsorbates [10]. In particular, W has been investigated in many other aspects e.g. hydrogen saturation by low energy ion scattering [11], tritium retention by baking in hydrogen atmosphere [12] and deuterium permeation through W [13].

In this paper, a systematic comparison is made between tungsten thin films deposited by TVA and PS, with the help of analytical study of surface-induced reactions with an emphasis on surface-induced dissociations. CD_2^+ , CD_3^+ and Ar^+ ion beams are collided with a PS tungsten surface in the incident energy range from about 0 eV to 100 eV. We also report results of the impact of CD_2^+ , CD_3^+ and CD_4^+ upon impact on tungsten film by TVA. Secondary ion mass spectra are recorded by time-of-flight mass spectrometer.

2. EXPERIMENTAL DETAILS

2.1 Double focussing mass spectrometer

Secondary ion mass spectra (SIMS) were taken with the help of tandem mass spectrometer apparatus (B-magnetic sector, E-electric sector, S-surface, TOF-time-of-flight (BESTOF shown here in Fig. 1 (details in [14-16])). Relative abundance of the product ions as a function of incident ion energy, was also quantified, called ERMS energy resolved mass spectra. A Nier-type electron impact source is used to ionize gas phase molecules at pressures of about 10^{-5} Torr, with 74 eV electrons. Ions are extracted and accelerated to almost 3 keV for mass and energy analysis. Focused by an Einzel lens and retarded to E_{in} i.e. incident energy, ions strike the target surface at an impact angle of 45° . Full width at half maximum FWHM of the projectile ions beam was 100 meV while the ion currents were 100 pA for CD_2^+ and around 200 pA for CD_3^+ and CD_4^+ focussed to a cross section of 2 mm^2 (spot size calculated by ion beam simulations using SIMION). Secondary ions were analysed by time-of-flight MS; a flight tube of 80 cm in length. A double-stage multi-channel plate analyzer with a time resolution of 8 ns per channel is used to collect these ions.

Keeping the shutter valve between the collision chamber and sector field mass spectrometer closed,

base pressure in the collision chamber was about 10^{-9} Torr. This pressure could increase to a maximum one order of magnitude while opening the said beam-line valve. Under these pressure conditions, it is obvious that the surface remained covered with hydrocarbons.

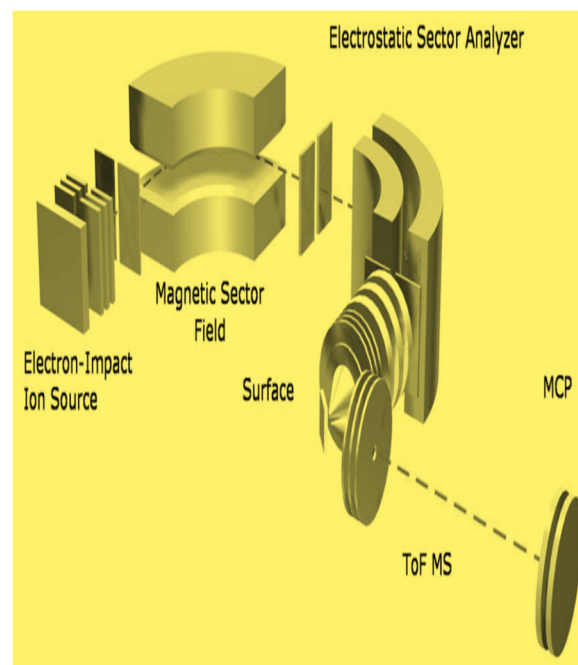


Fig. 1: SCHEME OF MASS SPECTROMETER BESTOF

2.2 Tungsten film deposition

The tungsten films of thickness 34 nm, are deposited on stainless steel covered with residual-pressure hydrocarbons by TVA, that involves production of a high potential (300-2000 V) and low current (0.1 - 2 A) plasma, in the pure vapours of the tungsten metal to be deposited [17,18]. Important parameters include: cathode filament current; 150 A, arc current; 2 A, the arc voltage; 1000 V d.c. A smooth film (despite the presence of few droplets), with a roughness in the range of 20-30 nm, is seen using atomic force microscopy.

Another tungsten thin film deposited on carbon by PS is obtained ASDEX-Upgrade vacuum vessel. High-density plasma spray technique is used to coat tungsten on graphite whereas a layer of $10 \mu\text{m}$ thick Re is applied between carbon and tungsten that prevents carbon diffusion leading to tungsten carbide formation.

3. RESULTS AND DISCUSSION

3.1. Surface Induced Reaction (SIR) studies

Regarding fusion related investigations for low-energy interactions i.e. below 200 eV, there exist only few experimental studies especially for the interactions of hydrocarbons. But in last few years, surface-induced reactions including dissociation, have been developed as a method to study the fragmentation processes [19-21]. The available data is scarce for deuterated hydrocarbon species which is definitely much more relevant regarding fusion plasma. Therefore, we have extended our ion-surface interaction studies from those reported in [22] to fusion relevant tungsten films. Mass spectra of product ions resulting from the interactions of CD_2^+ , CD_3^+ and Ar^+ with PS tungsten surfaces and CD_2^+ , CD_3^+ and CD_4^+ during the impact with TVA tungsten films are measured on the double focussing mass spectrometer BESTOF. Respectively, incident energy resolved mass are also calculated which are relative abundances of projectile ions and product ions in percentages i.e. $I_{rel} = 100(I_i / \sum I_i)$.

At $E_{in} = 0$ eV (an average incident kinetic energy), only the projectile ion i.e. CD_2^+ m/z 16 can be seen (Fig.2) that results from two different processes induced at the surface. Elastically scattered ions are diverted towards the TOF by surface micro charges (or the electric fields in the interaction region close the surface) with full energy and in-elastically scattered

ions that practically hit the surface. In the TOF mass spectrum, we are able to see this difference in few measurements and the peak of the primary ion can be seen easily divided in two peaks at the top, shown in Fig. 2 inset.

For an understanding of dissociation processes and comparative quantification of the respective product ions, mass spectra taken at $E_{in} = 30$ eV taken after the collision of CD_2^+ for the said tungsten surfaces are shown in figure. 3. SID products for CD_2^+ m/z 16 can be seen during ion beam collisions with PS tungsten. Dissociation energetics yield that energy of about 4.65 eV is required in total, for $CD_2^+ \rightarrow CD^+ m/z 14 + D$. We have calculated from our earlier experiments that a 6 % of translational kinetic energy is transformed into internal energy of projectile ions i.e. in this case, 1.8 eV is *additionally* added into internal energy for molecule to be dissociated.

As stated elsewhere [23-25], these fragmentations of the projectile ions occur after striking surfaces, in a uni-molecular way. A very high yield of the projectile ions signs perhaps the higher reflectivity of the smooth TVA tungsten film.

Surface induced reaction products are also seen which are observed behaving similarly for both thin films. These are the ions formed as projectile ions or their dissociated products react with surface adsorbed hydrocarbons:

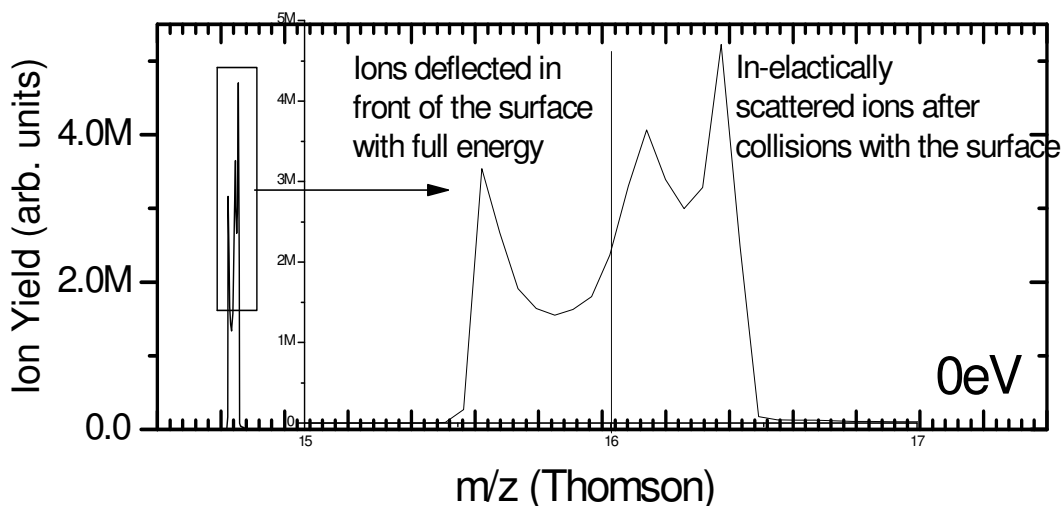


FIG. 2. SECONDARY ION MASS SPECTRUM (SIMS) OF CD_2^+ COLLIDING WITH A PLASMA SPRAYED TUNGSTEN (PSW) SURFACE AT $E_{in} = 0$ eV.

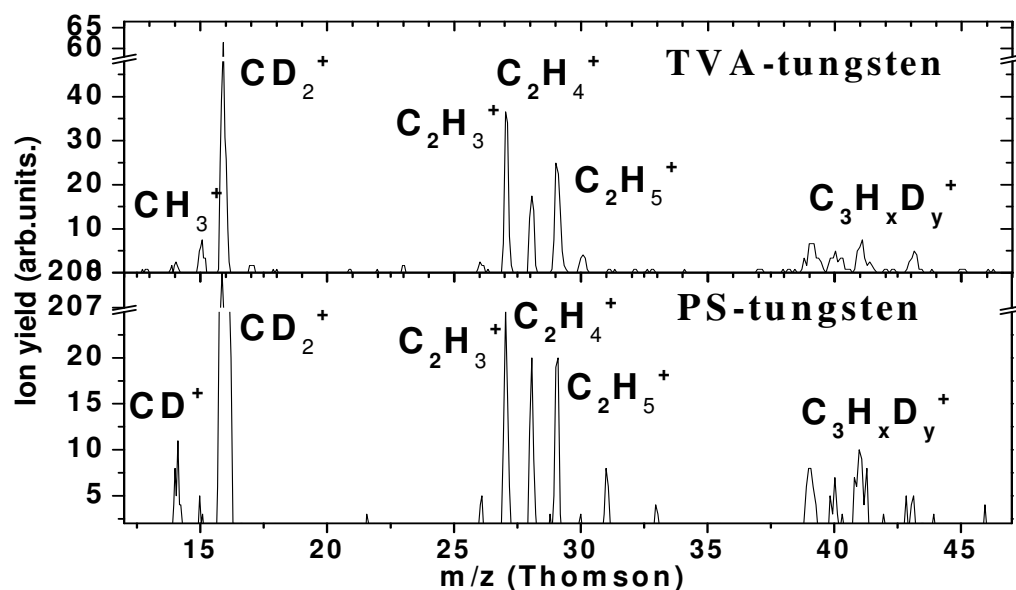
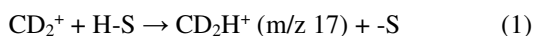
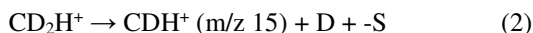


FIG. 3: PRODUCT ION MASS SPECTRA OF CD_2^+ INTERACTING WITH INCIDENT ENERGY OF 30 eV, WITH HYDROCARBON COVERED PS TUNGSTEN AND TVA TUNGSTEN FILMS.

- a) Hydrogen atom pickup reaction resulting the formation of CD_2H^+ m/z 17 is seen barely for TVA tungsten surface.



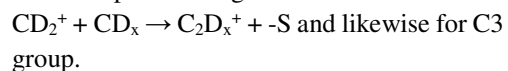
Further dissociation of this product results the formation of CDH^+ m/z 15 i.e.



- b) The product ions with even m/z i.e. $m/z = 26, 28$ and 30 of C2 group and $m/z = 40$ and 42 of C3 group result by either

i- reactions that result C-chains to build with e.g CH_2 group of surface hydrocarbons e.g. $CD_2^+ + CH_2-S \rightarrow C_2D_xH_y^+ + -S$ or

ii- chemical reactions of projectile ions with its own SID products e.g.



- c) The reaction products of odd m/z i.e. $m/z = 27, 29$ and 31 of C2 group of hydrocarbons and $m/z = 39, 41$ and 43 of C3 group, are a combination of i- pure surface-sputtered hydrocarbons e.g. $C_2H_3^+$ m/z 27 and $C_3H_3^+$ m/z 39 and ii- C-chain build-up reaction products formed by reactions given in subsection (b).

3.2. Ion yields

Reflection properties of the surfaces in bulk or in the form of thin films can be studied by the quantitative analysis of the reflected projectile ions as well sputtered ions. Although the absolute ion yields of these ions, depend strongly upon experimental conditions like pressure in the collision chamber, potentials at the secondary lenses of the lens stack including pulsing lens, but here we present primary results about the nature of the surfaces under normalized conditions.

The respective ratios of the molecular ions appearing as a result of physical sputtering of the surface adsorbed hydrocarbon layers is shown in Table 1. It is clear that the ratio of the yield m/z 27 to that of m/z 29 increases in the whole measured energy range from 1.10 to 1.47. Moreover, the ratio of the yield of m/z 39 to that of m/z 41 also increases from 0.55 to 0.90 but the ratio of the yield of m/z 39 to that of m/z 43 does not show a clear trend.

Total ion yields of all the secondary and deflected projectile ions is calculated, for an optimized ion current of 200 pA and 10 hours exposure time at $E_{in} = 10$ eV. Surface induced reactions are studied by four different projectile ions i.e. CD_2^+ , CD_3^+ and CD_4^+ and Ar^+ on two different surfaces i.e. PS and TVA

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tungsten. At an incident energy of 10 eV, we find that total ion yield of secondary ions is the *highest for tungsten film deposited by thermionic vacuum arc method*. Projectiles deflected in front of the surface contribute as major part of the ions that arrive the detector. Thus we propose a conclusion that these tungsten thin films made by TVA are *much more reflective and smooth* as compared to other investigated tungsten surfaces.

TABLE 1. RESPECTIVE RATIOS OF THE SECONDARY ION YIELDS AFTER COLLISION OF AR⁺ ON PS-W.

Incident energy of the projectile ion beam (eV)	Ratio of the yield of m/z 27 to the yield of m/z 29	Ratio of the yield of m/z 39 to the yield of m/z 41	Ratio of the yield of m/z 39 to the yield of m/z 43
30	1.10	0.56	0.98
50	1.12	0.63	1.10
100	1.33	0.65	0.96
150	1.47	0.90	1.33

The total ion yield of all the product ions and projectile ions plotted against incident energy can be analyzed partially to study the nature of the phenomenon induced by the surface. In Fig.4 (upper graph), breakdown curves of the projectile ions (CD₂⁺, CD₃⁺ and Ar⁺) after interaction with PS tungsten, are shown. Here the projectile ions are dissociated via surface induced excitation or neutralized via charge exchange with surface adsorbed hydrocarbons. Chemical reactions between projectile ions or its dissociated products with adsorbates, also contribute to total ion yields. Physical sputtering of surface adsorbates by energetic beam results into a sharp increase in the total ion yield. By analyzing the similar curves for TVA tungsten surfaces, in the light of above mentioned processes, physical sputtering of the surface adsorbed hydrocarbons does not seem to be very prominent phenomenon in the higher incident energy range measured. Comparative lesser sputtering yield from TVA tungsten surface signs the lesser content of adsorbed hydrocarbons and/or the smoothness of thermionic vacuum arc tungsten film as compared to plasma sprayed tungsten.

Fig.5 shows the relative abundances of projectile ions plotted against incident energies, that are calculated after the impact of CD₂⁺ and CD₃⁺ with polished

stainless steel surface, PS and TVA tungsten thin films, for energy up to 100 eV. The relative ion abundance of CD₂⁺ (Fig. 5 (a)) is always higher for

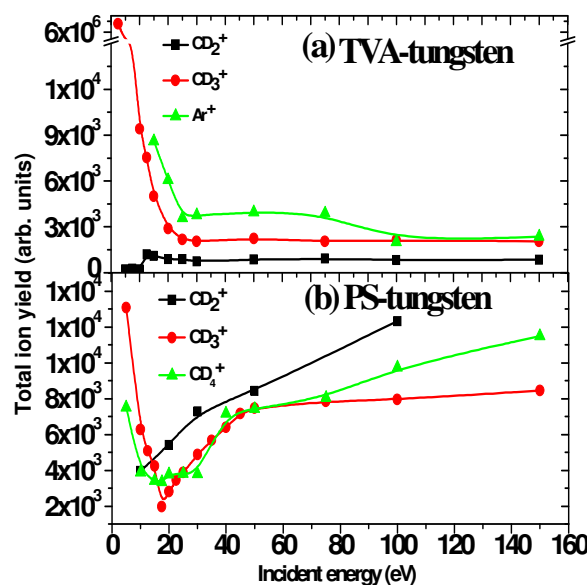


FIGURE 4: TOTAL ION YIELDS OF IONS AGAINST INCIDENT ENERGY FOR CD_x⁺ AND AR⁺ AFTER IMPACT WITH TUNGSTEN THIN FILMS.

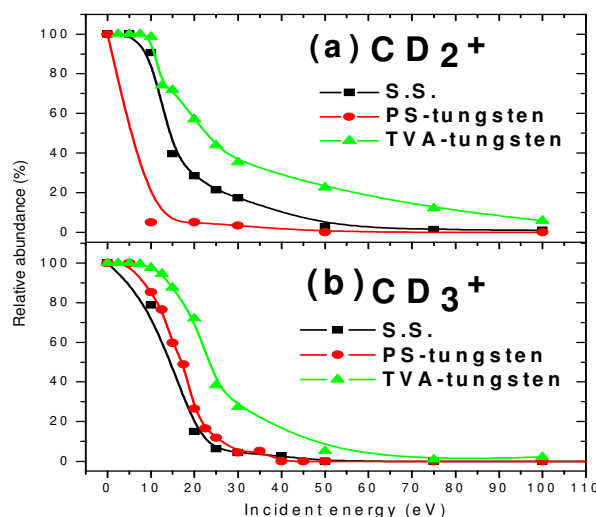


FIG.5: RELATIVE ION YIELDS OF PROJECTILE IONS AGAINST INCIDENT ENERGY FOR (A) CD₂⁺ AND (B) CD₃⁺

TVA tungsten surface in comparison to other investigated surfaces (twice with respect to that with S.S. at 15 eV to a maximum of about 20 times at 50 eV). As translational energy may transform to internal energy of surface excited molecules, during interaction with surface resulting, surface induced dissociation processes, it is obvious from these results

that the TVA tungsten film contributes to a lesser extent in such transformation.

In Fig. 5 (b), relative abundance of CD_3^+ ions is seen higher for TVA tungsten film, in the measured energy range with respect to that with other target materials indicating the smaller amount of energy transfer from kinetic to internal modes which ultimately increases the fragmentation threshold on the energy scale.

4. CONCLUSIONS

We have successfully studied surface induced dissociation properties and reflection properties of fusion relevant tungsten surfaces with the help of ion-surface collisions. Small hydrocarbon cations are interacted with two different thin films of tungsten made by thermionic vacuum arc and plasma spray methods deposited on stainless steel and carbon, respectively. The TVA tungsten thin films, in this preliminary study, seem to be much more reflective and even smoother on the micro level when compared to PS tungsten films.

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